Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,765	CHAN ET AL.	
Examiner	Art Unit	
Tyrone W. Smith	2837	

SEARCHED					
Class	Subclass	Date	Examiner		
318	138 439 254 700 685 696	3/14/2006	TS		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
318	138 439	3/14/2006	TS	
318	254 700	3/14/2006	TS	
318	685 696	3/14/2006	TS	
PGPub Search (see attached)		3/14/2006	тѕ	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
United States Patent Databxe Derwent Japanese European Non-patent Literature	3/14/2006	TS	
East Search (see attached)	3/14/2006	TS	